

BLANK PAGE



Indian Standard

METHODS OF TEST FOR RIGID CELLULAR THERMAL INSULATION MATERIALS

PART 6 HEAT DISTORTION TEMPERATURE

UDC 678.077-405.8:536.072.35:662.998



@ Copyright 1985

INDIAN STANDARDS IN STITUTION
MANAK BHAVAN, 9 BAHADUR SHAH ZAFAR MARG
NEW DELHI 110002

Indian Standard

METHODS OF TEST FOR RIGID CELLULAR THERMAL INSULATION MATERIALS

HEAT DISTORTION TEMPERATURE PART 6

Thermal Insulation Materials Sectional Committee, CDC 37

Chairman

Representing

DR B. C. RAYCHAUDHURI

Indian Institute of Technology, Delhi

Members

SHRI U. C. AGRAWAL

Synthetic Foams Ltd, New Delhi

SHRI RAJEEVA KANSAL (Alternate)

CHEMIST & METALLURGIST

Research, Design and Standards Organization (Ministry of Railways), Lucknow

ASSISTANT RESEARCH OFFICER (CM-II) (Alternate)

SHRI N. N. GOYAL

Fibreglass Pilkington Ltd, Bombay

SHRI G. K. TAKIAR (Alternate)

SHRI A. K. GUPTA

Hyderabad Asbestos Cement Products Ltd. Hyderabad

SHRI K. V. GURUSWAMY

Indian Oil Corporation, New Delhi

SHRI R. K. LAKHANPAL (Alternate)

Steel Authority of India Ltd, Ranchi

SHRI A. V. HINGORANI SHRI B. S. VANKATARAMIAH (Alternate)

Directorate General of Technical Development,

SHRI I. K. KAPOOR

New Delhi

SHRI K. V. SAMPATH (Alternate) SHRI A. S. R. MURTHY

Ministry of Energy

SHRI S. M. C. PILLAI SHRI RAM GOPAL (Alternate) National Thermal Power Corporation, New Delhi

DR M. PRASAD

Central Mechanical Engineering Research Institute (CSIR), Durgapur

SHRI R. N. BANERJEE (Alternate)

SHRI R. P. PUNJ

Puni Sons Pvt Ltd, New Delhi

Shri J. K. Chopra (Alternate) Shri P. K. Reddy

Mettur Beardsell Ltd, Madras

SHRI S. RAVINDRAN (Alternate) Dr. H. C. Roy

Projects & Development India Ltd, Sindri

SHRI S. P. S. KHALSA (Alternate)

(Continued on page 2)

C Copyright 1985

INDIAN STANDARDS INSTITUTION

This publication is protected under the Indian Copyright Act (XIV of 1957) and reproduction in whole or in part by any means except with written permission of the publisher shall be deemed to be an infringement of copyright under the said Act,

IS: 11239 (Part 6) - 1985

(Continued from page 1)

Members Representing

SHRI R. SHANKARAN Bharat Heavy Electricals Ltd, Hyderabad SHRI D. S. UPADHYAYA (Alternate I)

SHRI B. K. DUBEY (Alternate II

Dr G. K. Sharma Indian Institute of Technology, Bombay SHRI N. SRINIVAS Lloyd Insulations (India) Pvt Ltd, New Delhi

SHRI C. P. KHANNA (Alternate)

Shri M. Bala Subramaniam BASF India Limited, Bombay SHRI R. N. GANJOO (Alternate)

SHRI V. A. SURA

SHRI NIMISH V. SURA (Alternate PIBCO Ltd, New Delhi

SHRI T. UDAYAKUMAR

SHRIMATI U. ROY (Alternate)

DR V. V. VERMA Central Building Research Institute (CSIR), Roorkee

Newkem Products Corporation, Bombay

SHRI S. P. JAIN (Alternate)

SHRI V. P. WASAN National Physical Laboratory, New Delhi

SHRI K. N. BHATNAGAR (Alternate)

SHRI SATISH CHANDER Director General, ISI (Ex-officio Member)

Director (Chem)

Secretary

SHRI P. S. ARORA Senior Deputy Director (Chem), ISI

Panel for Terminology and Methods of Test for Thermal Insulation, CDC 37: P1

Convener

DR B. C. RAYCHAUDHURI Indian Institute of Technology, New Delhi

Members

DR K. N. AGARWAL Central Building Research Institute (CSIR), Roorkee

DR V. V. VERMA (Alternate)

SHRI U. C. AGRAWAL Synthetic Foams Ltd, New Delhi

SHRI RAJEEVA KANSAL (Alternate)

SHRI A. K. GUPTA Products Hyderabad Asbestos Cement Ltd,

Hyderabad

Punj Sons Pvt Ltd, New Delhi

PIBCO Ltd, Calcutta

Bharat Heavy Electricals Ltd, Hyderabad

Project & Development India Ltd, Sindri

Indian Institute of Technology, Bombay

SHRI M. SAMBASIVA RAO (Alternate)

SHRI D. K. KANUNGO National Test House, Calcutta

SHRI TRIDIL CHAUDHURI (Alternate)

Shri R. P. Punj

SHRI J. K. CHOPRA (Alternate)

SHRI R. SHANKARAN DR S. K. SHARMA

SHRI B. K. JHA (Alternate)

SHRI G. K. SHARMA

SHRI T. UDAYAKUMAR SHRIMATI U. ROY (Alternate)

SHRI V. P. WASAN National Physical Laboratory, New Delhi

SHRIK. N. BHATNAGAR (Alternate)

2

Indian Standard

METHODS OF TEST FOR RIGID CELLULAR THERMAL INSULATION MATERIALS

PART 6 HEAT DISTORTION TEMPERATURE

0. FOREWORD

- 0.1 This Indian Standard was adopted by the Indian Standards Institution on 25 March 1985, after the draft finalised by the Thermal Insulation Materials Sectional Committee had been approved by the Chemical Division Council.
- **0.2** In the preparation of this standard, considerable assistance has been drawn from BS 4370 Part 3: 1974 'Methods for measurement of heat distortion temperature, determination of friability and measurement of coefficient of linearthermal expansion at low temperatures issued by the British Standards Institution.
- **0.3** In reporting the result of a test made in accordance with this standard, if the final value, observed or calculated, is to be rounded off, it shall be done in accordance with IS: 2 1960*.

1. SCOPE

- 1.1 This standard prescribes the method for determination of the heat distortion temperature of rigid cellular thermal insulation materials using a cantilever test specimen.
- 1.1.1 The test is useful for the initial screening of rigid cellular thermal insulation materials.

Note – The heat distortion temperature values obtained are dependent on the specified method of test and the loading conditions used and no correlation with the maximum temperature of use of a material in service is implied.

2. TERMINILOGY

2.1 For the purpose of this standard the definition given in IS: 3069-1965† and the following shall apply.

^{*}Rules for rounding off numerical values (revised).

[†]Glossary of terms, symbols and units relating to thermal insulation materials.

IS: 11239 (Part 6) - 1985

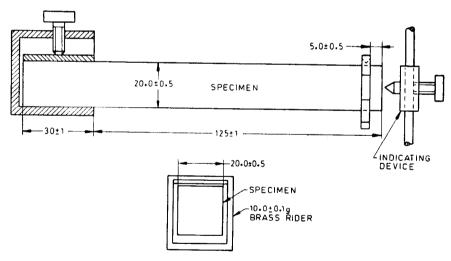
2.1.1 Heat Distortion Temperature—The temperature at which a cantilever test specimen under the specified loading conditions deforms by specified amount when its temperature is raised at a uniform rate.

3. CONDITIONING

3.1 The test specimen shall be conditioned for a period of not less than 16 hours at 27 ± 2 °C and 65 ± 5 percent relative humidity.

4. APPARATUS

- **4.1 Circulating-Air Oven** In which a linear temperature rise of $50 \pm 1^{\circ}\text{C/h}$ can be maintained and such that the temperature in the vicinity of the test specimen is uniform to within $\pm 2^{\circ}\text{C}$.
- **4.2 Clamp** To support the test specimen horizontally inside the oven.
- 4.3 Weights and Weight Holder Such that a mass of 10 ± 0.1 g can be attached to the free end of the test specimen, as shown in Fig. 1.



All dimensions in millimetres.

FIG. 1 DIAGRAM OF TEST APPARATUS

- **4.4 Indicating Device** To determine when the free end of the test specimen has fallen by 10 ± 1 mm, as shown in Fig. 1.
- **4.5** Means for measuring the temperature of the air in the immediate vicinity of the test specimen to an accuracy of $\pm 1^{\circ}$ C.

4.6 Means for measuring the dimensions of the test specimen as specified in IS: 11239 (Part 1)-1985*.

5. TEST SPECIMENS

5.1 The test specimens shall be rectangular bars of the following dimensions:

Length	$155~\pm~2~\mathrm{mm}$
Width	$20 \pm 0.5 \text{ mm}$
Thickness	$20 \pm 0.5 \text{ mm}$

5.2 The test specimen shall be cut without deformation of the original cell structure and shall be free of surface skins, voids or blemishes. Hot wire cutting is not permissible.

Note-A V-Notch may be provided to locate the rider $5\pm0^{\circ}5$ mm from the free end of the specimen.

5.3 A minimum of three test specimens shall normally be tested from each sample. If the samples are suspected of being anisotropic, one set of specimens shall be taken such that their length is parallel to the suspected directions of anisotropy of the material and a second set shall also be taken such that their length is perpendicular to the suspected direction of anisotropy.

6. PROCEDURE

- 6.1 Determine the dimensions of the test specimen in accordance with IS: 11239 (Part 1) 1985* to ensure that they meet the requirement of 5.
- **6.2** Clamp the test specimen horizontally inside the oven so that there is no significant deformation of the cell structure and the effective length of the cantilever is 125 + 1 mm.
- **6.3** Attach a total mass of 10 ± 0.1 g at a distance of 5 ± 0.5 mm from the free end of the test specimens as shown in Fig. 1. Position and adjust the indicating device so that the deflection of the free end of the test specimens may be noted.
- **6.4** Starting at room temperature, raise the temperature of the oven at a uniform rate of $50 \pm 1^{\circ} G/h$ as measured by the air temperature adjacent to the test specimen. When the free end of the test specimen has dropped by 10 ± 1 mm as shown by the indicating device, record the temperature of the air surrounding the specimen as the heat distortion temperature of the specimen.

^{*}Methods of test for cellular thermal insulation materials: Part 1 Dimensions.

IS: 11239 (Part 6) - 1985

Note — In the case of consecutive tests the oven and test apparatus should be allowed to return to room temperature before a new test specimen is introduced.

7. REPORT

- 7.1 The test report shall include the following:
 - a) Reference to this standard;
 - b) Description and identity of the materials;
 - c) Individual test results for each direction of test;
 - d) Median test results for each direction of test reported as the heat distortion temperature of the material for that direction; and
 - e) Direction of anisotropy, if any, relative to the length of the test specimens.